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Screening for Metals by X-Ray Fluorescence Spectrometry Using a Single Calibration Standard

Alan D. Hewitt

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# Abstract

Analysis for copper, zinc, arsenic and lead was performed on a variety of solid particle matrices using a portable, high-resolution X-ray fluorescence (XRF) spectrometer. All quantitative determinations were based on an instrumental calibration method that uses a single certified reference material to establish elemental response factors and the Compton  $K_{\rm c}$  peak to normalize for matrix discrepancies. This simple approach to XRF analysis circumvents the need to acquire matrix matched standards for either empirical coefficients or fundamental parameter methods of calibration. Preliminarly results show that response factor/Compton  $K_{\rm c}$  peak normalization is a promising approach when screening for these metals in soils, dust, paint chips and incinerated studge.

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Engineering Laboratory

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# PREFACE

This report was prepared by Alan D. Hewitt, Research Physical Scientist, Geological Sciences Branch, Research Division, U.S. Army Cold Regions Research and Engineering Laboratory

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# Screening for Metals by X-Ray Fluorescence Spectrometry Using a Single Calibration Standard

ALAN D. HEWITT

#### INTRODUCTION

Both natural and anthropogenic levels of metals in soil are of human health concern. X-ray fluorescence (XRF) spectrometry is a nondestructive method of total metal analysis that requires very little sample preparation. For this reason XRF is an efficient and cost-effective means of identify. ing and quantifying pollutant metals in solid materials during remedial investigations and feasibility studies (RI/FS) for hazardous waste site investigations. Moreover, on-site screening for pollutant metals with XRF has received the approval of the U.S. Environmental Protection Agency (EPA 1987). The data quality specification often recommended for field screening by XRF analysis is a precision of ±10%, an accuracy of ±50% and detection limits of less than 1000 parts per million (Raab et al. 1987). The main objective during field screening exercises is to quickly locate and delineate the areas of heaviest contamination. Several studies have demonstrated XRF's ability to satisfy these criteria by using either laboratorybased (Frust et al. 1985, Grupp et al. 1989, Watson et al. 1989, Harding 1991) or field-portable instruments (Piorek and Rhodes 1988, Ash et al. 1991, Carlson and Alexander 1991, Driscoll et al. 1991, Garby 1991).

In the past most of the field-portable XRF site screening was performed with systems equipped with gas proportional detectors. This type of detector has a spectral resolution of about 1000 electronvolts (eV), restricting its suitability to cases where a single metal was being determined or where the metals of interest have well-resolved X-ray fluorescence peaks. Recently a new generation of field-portable XRF systems have become available (Ashe et al. 1991, Driscoll et al. 1991). They are equipped with silicon (drifted with lithium) [Si(Li)] or mercuric iodidc (HgI<sub>2</sub>) detectors with resolutions of 170 and 300 eV, respectively. These field-transportable, high-resolution systems can provide unambiguous qualitative identification of

more complex mixtures of metals in environmental samples by generating the same unique metal spectra as the more expensive laboratory-based systems. The major difference between field and laboratory instruments is that the former have a sealed radioisotope as the primary radiation source. These sources are smaller and less energetic, so the portable instruments are not as sensitive as most laboratory-based systems. The selection and number of sources that can be installed in a fieldportable XRF instrument control the range of elements that can be detected. This combination of sealed primary sources, along with a detector requiring a liter or less of liquid nitrogen, microprocessors and rechargeable battery packs, has allowed for the construction of rugged, compact and lightweight instruments capable of several hours of remote operation (manufactured by HNU Systems Inc., Spectrace Instruments Inc. and Outokumpu Electronics).

Today the manufacturers of these field-portable, high-resolution XRF systems are focusing their attention on the user friendliness and the robustness of applications for environmental sample analysis. Applications that are insensitive to sample matrices are necessary in order to lima the number of calibration standards required to handle the diverse range of samples that can be encountered during a hazardous waste interiorestigation (e.g. soil composition, sludge, dust, paint chips, etc.).

Two of the field-portable XRF instruments currently being marketed are capable of analyses based on empirical calibration coefficients, which requires the entry of several site-specific or generic matrix standards (UNU Systems Inc. and Outokumpu Electronics). The HNU instrument also has a Compton peak normalization analysis method. The other manufacturer (Spectrace Instruments, Inc.) offers only a fundamental parameters analysis method for environmental samples. The major advantage of using fundamental parameters for quantitative metal evaluations is that

the sample analysis is not delayed by having to either establish site-specific standards or enter multiple calibration points for each sample matrix or both.

Until robust (matrix-insensitive) fundamental parameter applications are universal, Spittler\* has proposed that the accuracy necessary for a preliminary site investigation, for many of the more frequently encountered metal pollutants such as lead (Pb), arsenic (As) and zinc (Zn), could be achieved by a single-point instrumental calibration method that includes a matrix normalization parameter. This method requires only a single certified reference material containing the analytes of interest in a matrix that is physically consistent with the samples (particles), plus normalization of the incoherent radiation backscattering. Incoherent radiation backscatter is caused by the light elements and the analyte concentration in the sample matrix. Traditionally the ratio of the incoherent (Compton) and coherent (Rayleigh) backscatter has been used for matrix correction with environmental samples (Nielson and Sander: 1983, Christensen and Drabaek 1986, Rachetti and Wegscheider 1986). However, to fulfill the objective of field screening, only the intensity of the former peak is necessary.

In this study I evaluated the utility of environmental sample analysis based on a single certified standard and normalization for the incoherent backscattering. This preliminary effort covered the quantification of copper (Cu), Zn, As and Pb in a wide variety of solid particle matrices.

#### XRF ANALYSIS

The detection of metals by XRF analysis is the result of the emission of element-specific energies (photons) that occurs when an electron from an outer orbital loses energy in order to fill a void in an inner shell. This emitted energy is called X-ray. fluorescence and is measured in kiloelectronvolts. (keV; 1 keV = 1000 eV). The electron vacancy in the inner shell (the nonvalence shell) is created by exposure to a beam of gamma or X-ray energy that is close to and above its excitation energy (Fig. 1). The probability for an electron to become excited and ejected from a shell increases with a decreasing difference between incident and excitation energy levels. For example, the incident energies (two ievels) coming from the primary cadmium -109 (109Cd) X-ray source are 21.16 and 22.99 keV, which are more likely to cause electrons to be lost.

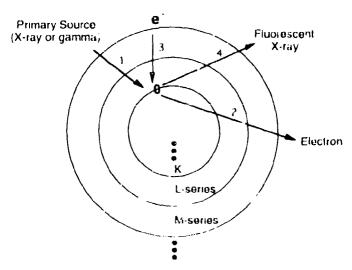
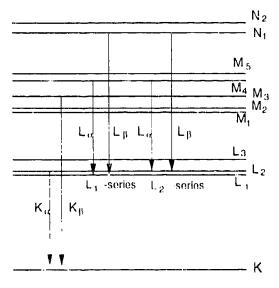


Figure 1. Process of X-ray fluorescence. The numbers indicate the order of events.

<sup>\*</sup>Personal communication, T.M. Spittler, U.S. LPA, Environmental Services Division, Region 1, Lexington, Massachusetts, 1989.



Ligure 2.  $K_{tt}$ ,  $K_{B}$ ,  $L_{tc}$  and  $L_{B}$  X rays.

from the K shell of selenium (Se), with an excitation energy level of 12.66 keV, than from Cr, with a corresponding excitation energy level of 5.989 keV.

Of the metals detectable by XRF analysis, the & and L electron shells are the ones most frequently

Table 1. Primary sources and analyte lines for metals of environmental concern that can be detected by XRF spectrometry.

		l mission	on lines (keV)		
Metals	٨,,	$\lambda_{jt}$	$L_{\rm st}$	$I_{\mathcal{H}}$	
104Cd X-r	ay source				
( r	541	5.95			
Mn	5.89	6.49			
1 ·	6.40	7 (4)			
Co	6.95	765			
Ni	7.47	8 40			
Cu	н (Ц	H 07			
Zn.	863	961			
As.	10.5	11.8			
441	11.2	12.6			
l ig			9.98	11.9	
H.			10 3	123	
Ph			10.5	12.6	
241Am X-	ray source				
Ag	221	14			
cd	23.1	26.4			
511	25.2	28.8			
Sh	26/2	101			
Ba	32.0	to R			

filled. These two letters, along with  $\alpha$ ,  $\beta$  and  $\gamma$  subscripts denoting the outer shells from which the electrons fell (Fig. 2), serve as the nomenclature for the discrete spectral energies measured. Moreover, since there is more than one atomic energy level (shell) from which an electron can fall, there are always at least two emission energies for each element (Fig. 2). For this reason the spectral energies of greatest interest for the analysis of pollutant metals are the  $K_{\alpha}$ ,  $K_{\beta}$  or the  $L_{\alpha}$ ,  $L_{\beta}$  spectral lines (Table 1).

Probability also comes into play for the electrons filling the void created. The spectral intensity ratios of the  $\alpha$  and  $\beta$  emission peaks is 7:1 when a K shell is filled and 9:6 for the L shells. It is much easier to observe these emission peak ratios with a high-resolution XRF spectrometer, thus aiding in the identification of a sample's elemental composition. Furthermore, since a high-resolution XRF can resolve all these  $\alpha$  and  $\beta$  peaks, it allows for the selection of a secondary peak for quantitative analysis when the energies of two emission peaks from different elements overlap.

Figure 3 is an example of the spectrum obtained with a high-resolution portable XRF system. This analysis was performed on an aqueous solution containing 1000 mg/L each of Cr, nickel (Ni), Cu, Zn, As and Se. The intensities of each characteristic  $K_{\alpha}$  peak increases for the same analyte concentration because discrete elemental excitation energies are successively closer to the incident energy generated by the  $^{109}{\rm Cd}$  radioactive source. In addition, the 7.1 intensity ratio between  $K_{\alpha}$  and  $K_{\beta}$  peaks can be seen for Zn, As and Se.

# INSTRUMENTATION

The instrument used in this study was the  $\lambda$ Met 920 (Outokumpu Electronics) X-ray spectro photometer. This system is equipped with a Si(Li) energy dispersive detecte i, a surface analysis probe and 109Cd and americ in 241 (241Am) primary radioactive sources. The combination of these two primary sources allows for the estimation of all the metals listed in Table 1. The Si(Li) semiconductor detector has a resolution of 170 eV and is cooled by a 0.5 I. liquid nitrogen reservoir. A preamplified signal is sent from this detector to a multi-channel analyzer (MCA), which separates the energy spec trum into 2048 channels. These channels correspond to spectral energies (keV), and the number of counts stored in each channel indicates signal intensity. The MCA is housed in a computer, the

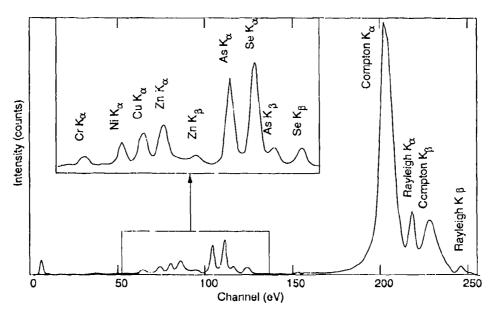


Figure 3. Spectrum of a solution containing 1000 mg/L of Cr, Ni, Cu, Zn, As and Se.

selection of which allows the system to either be capable of eight hours of battery-pack-powered, in-situ analysis or continuous, AC-powered, onsite analysis.

Figure 3 is an example of a 256-channel spectral output. All of the major emission peaks of these elements are well resolved, allowing for rapid elemental identification. In comparison, gas proportional detectors, with a resolution of around 1000 eV, would not be capable of resolving the Ni, Cu and Zn emission peaks or the As and Se peaks shown in Figure 3 (Table 1).

The X-Met 920 system was configured for onsite analysis of bulk samples held in either 31- or 40 mm-diameter cups. Field samples collected for on-site analysis are often dried and sieved prior to analysis. Several studies have found that these two operations can be performed in less than a couple of hours, making it possible to analyze tens to a hundred samples in a single day (Crupp et al. 1989, Gabry 1991). The bulk of the particles in the samples analyzed during this study would pass through a 30-mesh sieve, thus having an average size of < 600 µm.

## **CALIBRATION**

Ideally a calibrais d XRF system establishes the total metal concentration in the portion of the sample that is irradiated during analysis. If the

sample medium is homogeneous, then this concentration estimate corresponds to the entire sample retained in the cup. Direct measurement of the intensities of the various discrete spectral energies for quantitative interpretation, however, is often confounded by other elements present in the sample due to absorption and enhancement effects. These effects, which are matrix-dependent, are most often corrected by either empirical coefticients or by fundament... parameter calibration methods.

Empirical coefficients are derived after several calibration standards have been analyzed. These standards can be made from well-characterized site-specific materials or by treating clean materials with known quantities of analytes or both. This torm of calibration requires the use of several standards bracketing the analyte concentration range of interest. For example, Table 2 shows that 18 standards were necessary for the analysis of a soil containing five metals over a range of 0 to 10,000 µg/g (Piorek and Rhodes 1988). The preparation and verification of these standards could delay the start of an investigation by as much as a week or more, particularly when contaminated site-specific materials are involved, because they must be confirmed by alternative methods of total analysis. Furthermore, if site-typical soil standards are used, attention should be paid to the sand, clay, calcium and iron content (Piorek and Rhodes 1988). Thus, several sets of calibration standards, one for

Table 2. Set of calibration standards for the analysis of metals in soil.

		Concentration (µg/g)						
No.	Cr	Cu	Zn	Λs	Pb			
1	0	0	0	0	4960			
2	0	0	0	4957	0			
3	0	0	4611	0	0			
4	0	4907	0	()	0			
5	3304	0	0	0	0			
6	6251	6091	3517	2811	937			
7	322	241	998	9656	3862			
8	1965	1964	922	491	122			
9	81	488	458	977	2929			
10	2423	9080	8520	6356	1816			
11	1265	949	6230	3794	6640			
12	4530	3881	228	243	485			
13	161	2898	1813	120	9660			
14	0	0	0	0	0			
15	0	2916	4560	0	0			
16	0	4857	2734	0	0			
17	0	0	0	4934	2960			
18	0	0	0	2961	4935			

each specific soil type, may be necessary for a single site.

Fundamental parameter analysis is based on physical constants (i.e. mass absorption coefficients, jump ratios and fluorescence yields), which eliminates the need for several calibration standards (Figura 1987, 1993). However, as with empirical calibration methods, the best accuracy is obtained when the reference standard has a particle size and matrix density similar to the samples being analyzed. This requirement may also impede investigations, since very few commercial reference materials are now available. Moreover, the multiple-variable approach of analysis used by both fundamental and empirical calibration methods rely on commercial software development and microprocessing, which leaves the analyst with a black-box approach to environmental sample analysis.

The analysis method used in this study for Cu, Zn, As and Pb relies completely on the measurement of the intensity of the  $K_{\alpha}$ ,  $K_{\beta}$ ,  $L_{\alpha}$  or  $L_{\beta}$  spectral line for a specific element, along with the Compton  $K_{\alpha}$  backscatter peak (Fig. 3). This method of analysis allows for the determination of metal concentrations in environmental samples of similar physical state (particles <600  $\mu$ m) to be performed once element-specific response factors have been established using a certified reference material. For this study a finely ground soil, SRM 2710 certified

reference soil from the National Institute of Science and Technology (NIST), was used to establish the analyte response factors. The peak counts (intensities) used to establish the response factors for Cu, Zn, As and Pb are shown in Table 3. Even with a high-resolution XRF instrument, the As  $K_{\alpha}$  and Pb  $L_{\alpha}$  lines (10.532 and 10.549 keV, respectively) overlap, so the As  $K_{\beta}$  and Pb  $L_{\beta}$  peaks were used.

To perform this method of analysis with the 920 X-Met system, the energy spectrum from each analysis was saved and transformed into a 256-channel spectrum for close examination. This also

Table 3. Response factor determinations for Cu, Zn, As and Pb based on the SRM 2710 certified reference material.

	Cu	Zn	$\Lambda s$	Pb
Response fac	tor (intensity	/concentrat	ion)	
Day 1	12.0	33.9	1.09	39.5
Day 2	11.9	34.8	0.90	38.0
Day 3	12 3	34.4	1.04	39.6
Average	12.1	34.4	1.01	39.0
Std. dev.	0.21	0.45	0.098	0.90
% RSD	1.7	1.3	9.7	2.3
SRM 2710 co	ncentration (	μg/g)		
	2950	6952	626	5532

could have been done by measuring the intensities from the original 2048-channel spectrum. The former approach was used because it is easier to measure the intensity (counts) of smoothed peaks, and once transformed, six spectra could be displayed simultaneously. Intensities of both the baseline and the peaks of interest were then measured by selecting the appropriate spectrum channels. This was accomplished by placing a cursor on the selected channel (keV) and recording the counts (intensity) off of the display. Concentration estimates were manually determined by multiplying the baseline-corrected analyte signal intensity by the normalization factor, then by the response factor. The normalization factor is the product of the Compton  $K_{\alpha}$  peak intensity for the certified reference material divided by that of the samples.

# METHOD EVALUATION

#### **Detection limit**

The sensitivity of this instrument for the determination of Cr, Cu, Zn, As and Pb in soil was evaluated for an empirical coefficient calibration and for the manual interpretation of peak intensities. Both procedures used the method detection limit (MDL) (Federal Register 1984), and analyses were performed using the set of generic soil standards shown in Table 2. The MDL establishes detection limits based on the standard deviation of replicate measurements multiplied by the appropriate t value (one-sided) for n-1 degrees of freedom at the 99% confidence level. Table 4 shows the results for the seven analyses of an individual sample after calibrating the instrument over a high  $(10000 - \text{to } 0 - \mu g/g)$  and low  $(1000 - \text{to } 0 - \mu g/g)$  concentration range. The soil standards chosen for repeated analysis had reported analyte concentrations of approximately 1000 µg/g for the high calibration range and between 100 and 300 µg/g for the low range. Between each analysis the sample was removed from the detector and shaken. All analyses were performed for a 120-second measurement period.

## Analysis of reference and treated material

Several materials with either fortified or certified metal concentrations were used to assess the performance of the response factor/Compton  $K_{\alpha}$  peak normalization analysis method. Table 5 lists the certified reference materials purchased from either NIST or the Resource Technology Corporation (RTC). Those purchased from NIST have cer-

Table 4. Method detection limits (MDLs) established for metals in soil and precision of analysis for samples with concentrations near 1000 µg/g.

#### a. Method detection levels (µg/g)

	Empirical e	Empirical calibration			
Metal	10000-0	1000-0	intensity (counts)		
Cr	170	260	270		
Cu	96	59	54		
Zn	84	100	90		
As*	49	42	41		
Pb <sup>†</sup>	57	28	48		

#### b. Precision and accuracy of empirical calibration analysis

Metal	Accepted	Found	%RSD
Cr	1265	1270±53**	4.2
Cu	949	872±31	3.6
Zn	922	899+27	3.0
As	491	500±16	3.2
Pb	937	924±18	1.9

- \* As-Kβ.
- † Pb-L<sub>B</sub>.

tified concentrations for the total amount of metal present, whereas the RTC materials report certified values based on the USEPA SW846, 3000-series metal acid extraction procedures (U.S. EPA 1986). All of these materials were air dried and have an average particle size of <600 µm. Analysis was performed after placing 4- to 5-g quantities in a 31-mm-diameter analysis cup with a 0.2-mil polypropylene X-ray film window.

In addition to the certified reference materials, six different soils were spiked with Cr, Cu, Zn, As

Table 5. Certified reference materials used in the test.

National Institute of Standards and Technology SRM1579a—Powdered Lead Based Paint SRM2704—Buffalo River Sediment SRM2709—San Joaquin Soil SRM2710—Montana Soil SRM2711—Montana Soil

Resource Technology Corporation

CRM012—Incinerated Sludge

CRM013-Paint Chips

CRM014—Baghouse Dust

CRM020—Soil (from USEPA Superfund site)

CRM021—Soil (from contaminated waste site)

<sup>\*\*</sup> Average and standard deviation of seven analyses.

Table 6. Characteristics of the laboratory-treated soils.

Matrix	% sand	% silt and clay	Grain size* (mm)	Weight <sup>†</sup> (g)
Ottawa sand	100		0.4	4
Rocky Mountain Arsenal soil	NA	NA	NA	1
Lebanon Landfill soil	45	55	0.3	4
CRREL soil	NA	NΛ	NA	4
Tampa Bay sediments	95	5	0.2	4
Ft. Edwards clay	30	<i>7</i> ()	0.03	2

<sup>\* 95%</sup> cut off.

NA--Not analyzed.

and Pb using aqueous atomic absorption standards (Spittler and Fender 1979). Some of the soil characteristics and the subsample weights treated are shown in Table 6. These soils were air dried and thoroughly mixed prior to subsampling. Prior to treatment of each soil, six subsamples were placed into inverted 31-mm-diameter analysis cups. All analyte spikes were made by pipetting between 0.4 and 0.025 mL of concentrated 10,000mg/L aqueous pure element standards (AESAR/ Alfa, Johnson Matthey) directly onto the soil subsamples. An analyte spiking sequence was used so that none of the soil subsamples were treated with the same concentration twice (Table 7). In all, six cups were prepared for each soil matrix, five of which were spiked, increasing the Cr, Cu, Zn, As and Pb concentration by 1000, 500, 250, 125 or  $0 \mu g/g$ ; one served as the matrix blank. The total volume of solution added to each of the subsamples was less than 0.2 mL/g. This small volume of liquid completely wetted the exposed surface of the soil subsamples, with the exception of the one that had 70% slit and clay.

Once treated, the uncovered samples were placed in an oven at 95°C for one hour. After heating, the partially dried soil subsamples were

stirred with a stainless steel spatula. This process broke up the water-soaked grains, exposing a greater surface area and starting the homogenization process. Then the subsamples were returned to the oven for an additional hour of drying. After this second heat treatment, they were more carefully stirred, breaking up any clumps of soil that formed due to wetting. When no clumps remained and the soil subsamples were well mixed, the bottom of the analysis cup was covered with a 0.2-mil polypropylene X-ray cell film.

An analysis time of 120 seconds was used for Cu, Zn and Pb in the commercial reference materials. Determination for the metals in the laboratory-prepared soils and for As in the commercial reference materials required 300 seconds. All of the values for Cu, Zn, As and Pb were established relative to the SRM 2710 standard by using the response factor/Compton  $K_{\alpha}$  peak normalization method. Tables 8 and 9 show the measured Compton  $K_{\alpha}$  peak intensity (counts), along with the metal concentrations determined for each sample. No values were reported for Cr because no standard reference material was available with a total certified concentration greater than the MDL (270  $\mu$ g/g, Table 4).

Table 7. Treatment scheme for spiking soil subsamples with metals.

Subsample	Cr	Cu	Zn	As	Pb
 S1	1000	125	0	500	250
S2	500	250	1000	0	125
S3	250	()	125	1000	500
54	125	1000	500	250	0
S5	()	500	250	125	1000
Matrix blank	()	0	0	O	()

<sup>†</sup> weight of soil subsample spiked.

Table 8. Analysis of commercial reference materials based on single standard and Compton  $K_{\alpha}$  peak normalization.

			Compton		
Standard	Си	Zn	As	Pb	K <sub>α</sub> (counts)
SRM 1579a Powdered lead based paint				119,950* [160,000]†	29.6
SRM 2704 Buffalo River sediment	99 [31]	438 [302]	23 [26]	161 [130]	118
SRM 2709 San Joaquin soil	35 [105]	106 [91]	18 ND	19 [18]	124
SRM 2710 Montana soil	2,950 std**	6,952 std	626 std	5,532 std	101
SRM 2711 Montana soil	114 [167]	350 [3 <b>4</b> 3]	105 [138]	1,162 [1,100]	121
CRM 012 Incinerated sludge	3015 [2,470]	635 [342]		120 [114]	56.4
CRM 013 Paint chips				643 [460]	315
CRM 014 Baghouse dust				1,914 [2,080]	193
CRM 020 Soil from Superfund site	753 [687]	3021 [4,420]	397 [429]	5,195 [5,070]	54.1
CRM 021 Soil from cont. waste site	5,086 [8,720]	574 [549]	28 ND		23.7

<sup>\*</sup> Certified value.

# **RESULTS AND DISCUSSION**

The results in Table 4 show that the MDLs established by empirical coefficient calibration or by manually measuring peak intensities from the transformed spectra fulfill the requirement of providing detection capabilities <1000  $\mu$ g/g for Cr, Cu, Zn, As and Pb. This table also shows that the percent relative standard deviations (%RSDs) for empirical coefficients analysis of analyte concentrations around 1000  $\mu$ g/g were <10%. Likewise the %RSDs for the response factors shown for Cu, Zn, As and Pb in Table 3 were below 10%.

The results shown in Tables 8 and 9 demonstrate the usefulness of the single standard and Compton  $K_{\alpha}$  normalization approach to estimating Cu, Zn, As and Pb concentrations in a variety of solid particle matrices (i.e. dust, soil, paint chips

and sludge). The values determined for the certified reference materials (Table 8) only showed two determinations to be off by more than 50% for samples with certified concentrations above the established MDLs (Table 4). These determinations were for Cu both in the SRM 2704 and CRM 021 reference materials. The high Cu value for the CRM 021 reference material as established by the response factor/Compton  $K_{\alpha}$  peak normalization method is not necessarily incorrect, since the certified value is based on an acid extraction that may not represent the total amount present. In general the values below the MDLs were also in good agreement with the certified concentrations. Similarly the concentrations determined for the spiked soils (Table 9), after removing the background values (the mean of the 0 μg/g standard and the blank soil matrix) when they were found to be

<sup>+</sup> Values in brackets were established relative to the SRM 2710 after Compton peak normalization.

<sup>\*\*</sup> Certified standard used for response factors.

Table 9. Concentrations ( $\mu g/g$ ) of Cu, Zn, As and Pb determined for spiked soil matrices.

t 1aterial		Metal conce	ntrations (µg/g	)	Compton
and spike	Си	Zn	Λs	Pb	Kα (counts)
Ottawa sand					
1000 ppm	1010*	1020	1420	911	157
500 pprn	534*	458	381	411	153
250 ppm	264*	224	324	182	154
125 ppm	132*	127	72	139	156
0 ppm	69	ND	ND	ND	149
Matrix	64	18	ND	10	150
Rocky Mountain Arsena	l soil				
1000 ppm	897*	1050	1450	960	125
500 ppm	483*	459	608	470	124
250 ppm	209*	245	304	211	123
125 ppm	93*	153	105	125	125
0 ppm	76	ND	37	ND	123
Matrix	62	2	41	23	124
Lebanon Landfill soil					
1000ppm	859*	872	988	1192	122
500ppm	373*	469	536	423	119
250ppm	195*	224	305	264	119
125ppm	94*	140	78	135	119
0ppnı	99	2	ND	ND	118
Matrix	70	8	ND	24	124
CRREL soil					
1000 ppm	787*	870	782	1030	114
500 ppm	461*	- 541	635	597	112
250 ppm	250*	247	320	178	113
125 ppm	69*	152	26	130	114
0 ppm	86	48	48	ND	114
Matrix	62	59	ND	18	115
Tampa Bay sediments					
1000ppm	842*	939	1350*	936	144
500ppm	513*	486	560*	526	145
250ppm	250*	218	200*	219	143
125ppm	103*	159	73*	124	145
0ppm	60	11	220	7	142
Matrix	71	ทับ	249	NĎ	147
Ft. Edwards clay					
1000 ppm	711*	831	906	785	99.9
500 ppm	289*	454	491	344	99.1
250 ppm	144*	332	229	150	98.3
125 ppm	142*	171	104	108	99.7
0 ppm	199	81	ND	19	98.1
Matrix	218	80	ND	4	98.3

<sup>\*</sup> Average of 0 ppm and matrix subsamples subtracted.

greater than the MDL, were almost always within 50% of the expected values. This agreement between expected and determined concentrations occurred even though the normalization for matrix differences (the Compton  $K_{\alpha}$  peak normalization) ranged from 4.26 to 0.321, a relative change of

more than 400%. Thus, it appears that, at least for the XRF analysis of these four metals, the majority of analyte sorption or enhancement due to the matrix can be accounted for by Compton  $K_{\alpha}$  peak normalization.

Furthermore, since the estimated metal concen-

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trations coincided with the treatment levels, this technique would be very useful for locating hot spots, even when dealing with concentrations well below  $1000 \, \mu g/g$ . These findings support the concept that the initial screening performed for Cu, Zn, As and Pb does not require generic or matrixmatched standards or an instrument capable of performing fundamental parameter analysis.

These findings do not diminish the need for developing site-specific standards when attempting to obtain the greatest accuracy achievable with XRF analysis. Both empirical coefficients and fundamental parameter analysis are clearly capable of providing more than adequate results for screening applications. However, if soils of highly variable composition or other solid particle matrices are encountered during a site investigation, thereby precluding the use of a single set of matrixmatched standards, the Compton  $K_{\alpha}$  peak normalization method should prove to be effective without compromising the overall RI/FS objective. Similar studies have been planned for the analysis of chromium, iron, cobalt, nickel, mercury, thalium, selenium, silver, barium, tin, antimony and cadmium.

#### CONCLUSION

Determinations of Cu, Zn, As and Pb in a variety of soil matrices and three other solid-waste particulate materials were often within 50% of the expected values using a single certified reference material to establish the instrumental response factors and Compton  $K_{\alpha}$  peak normalization to account for matrix differences. This alternative approach to XRF metal analysis is very useful and timely when screening a variety of matrices during RI/FS activities.

# LITERATURE CITED

Ashe, J.B., P.F. Berry, G.R. Voots, M. Bernick and G. Prince (1991) A high resolution portable XRF HgI<sub>2</sub> spectrometer for field screening of hazardous waste. In Proceedings of the Second International Symposium on Field Screening for Hazardous Waste and Toxic Chemicals, February 12–14, Las Vegas, Nevada, p. 507–514.

Carlson, C.D. and J.P. Alexander (1991) Data quality assurance/quality control for field x-ray fluorescence spectrometry. In *Proceedings of the Second International Symposium on Field Screening* 

for Hazardous Waste and Toxic Chemicals, February 12–14, Las Vegas, Nevada, p. 525–532.

Christensen, L.H. and I. Drabaek (1986) Energy-dispersive X-ray fluorescence spectrometry of industrial paint samples. *Analytica Chimica Acta*, **188**: 15–24.

Driscoll, J.N., J.K. Marshall, C. Wood and T. Spittler (1991) A multifunctional portable X-ray fluorescence instrument. *American Laboratory*, July, p. 25–36.

**Figura, P.M.** (1987) Standardless quantitative X-ray fluorescence analysis using stored calibration constants. *American Laboratory*, February, p. 154–160.

Figura, P.M. (1993) Standardless X-ray fluorescence analysis of liquids. *American Laboratory*, July, p. 40–43.

Federal Register (1984) Definition and procedure for the determination of the method detection limit. Code of Federal Regulations, Part 136, Appendix B, October 26.

Furst, G.A., T. Spittler and V. Tillinghast (1985) Screening for metals at hazardous waste sites: A rapid cost-effective technique using X-ray fluorescence. Proceedings of the Sixth National Conference on Management of Uncontrolled Hazardous Waste Sites, Hazardous Materials Control Research Institute, Silver Spring, Maryland.

Gabry, J.C. (1991) Comparison of mobile laboratory XRF and CLP split sample lead results from a superfund site remediation in New Jersey. In *Proceedings of the Second International Symposium on Field Screening for Hazardous Waste and Toxic Chemicals, February 12–14, Las Vegas, Nevada,* p. 671–672. Grupp, D.J., D.A. Everitt, R.J. Bath and R. Spear (1989) Use of a transportable XRF spectrometer for on-site analysis of Hg in soils. *American Laboratory,* November, p. 32–40.

Harding, A.R. (1991) Low concentration soil contaminant characterization using EDXRF analysis. In Proceedings of the Second International Symposium on Field Screening for Hazardous Waste and Toxic Chemicals, February 12–14, Las Vegas, Nevada, p. 517–523.

Nielson, K.K. and R.W. Sanders (1983) Multielement enalysis of unweighed biological and geological samples using back scatter and fundamental parameters. *Advances in X-ray Analysis*, **26**: 385–390.

Piorek, S. and J.R. Rhodes (1988) A new calibration technique for X-ray analyzers used in hazardous waste screening. In *Proceedings of the Second International Symposium on Field Screening for Hazardous Waste and Toxic Chemicals, February 12–14*,

Las Vegas Nevada, p. 428-433.

Raab, G.A., D. Cardenas, S.J. Simon and A. Eccles (1987) Evaluation of a prototype field portable X-ray fluorescence system for hazardous waste-screening. Environmental Monitoring Systems Laboratory, Las Vegas, Nevada, EPA 1600 4-87 (021, National Technical Information Service, PB87 227633.

Rachetti, A. and W. Wegscheider (1986) A fundamental parameters approach including scattered radiation for mono-energetically excited samples in energy-dispersive X-ray fluores cence spectrometry. Analytical Chimica Acta, 188: 37-50.

Spittler, T.M. and W.A. Fender (1979) A study of

soil contamination and plant lead uptake in Boston urban gardens. Communications in Scil Science and Plant Analysis, 10(9): 1195–1210.

U.S. Environmental Protection Agency (1986) I. st. Mcthods for Evaluating Solid Waste Vol. 1B

U.S. Environmental Protection Agency (1987) Data quality objectives for remedial response activities, RLTS activities at a site contaminated soils and ground water TPA/540 Co-87/004, National Technical Information Service, PB88-131388 Watson, W., J.P. Walsh and B. Glynn (1989) Obsite X-ray fluorescence spectrometry mapping of metal contaminants in soils at Superfund sites American Laboratory, July.

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